

# 低噪声、低静态电流、高精度运算放大器 e-trim™ 系列

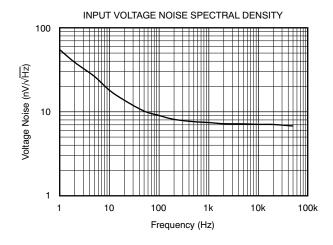
查询样品: OPA376-Q1, OPA2376-Q1, OPA4376-Q1

### 特性

- 符合汽车应用要求
- 低噪声: 1kHz 下为 7.5nV/√Hz
- 0.1 Hz 至 10 Hz 噪声: 0.8 μV<sub>PP</sub>
- 静态电流: 760µV(典型值)
- 低偏移电压: **5µV**(典型值)
- 增益带宽产品: 5.5MHz
- 轨至轨输出
- 单电源供电
- 电源电压: 2.2 V 至 5.5V
- 小型封装:
  - SC-70, SOT23, MSOP, TSSOP

### 应用

- · ADC 缓冲器
- 音频设备
- 医疗仪表
- 手持测试设备
- 有源滤波
- 传感器信号调节

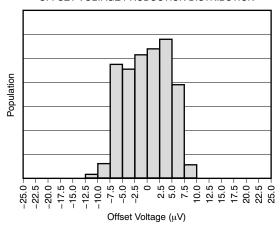


#### 说明

OPA376-Q1系列是支持 *e-trim* 的新一代低噪声运算放大器,可提供极高的 dc 精度与 ac 性能。 轨至轨输出、低失调(25 μV 最大值)、低噪声(7.5nV/√Hz)、950 μA 的最大静态电流以及 5.5 MHz 带宽使该部件非常适用于各种不同的高精度便携式应用。 此外,该器件还具有支持出色 PSRR的宽泛电源,理想适用于直接通过电池运行而无稳压的应用。

OPA376-Q1(单通道)采用 MicroSIZE SC70-5、SOT23-5 与 SO-8 封装。 OPA2376-Q1(双通道)采用 SO-8 封装。 OPA4376-Q1(四通道)采用 TSSOP-14 封装。 所有器件版本的特定工作温度范围均为—40℃至 125℃

#### OFFSET VOLTAGE PRODUCTION DISTRIBUTION



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

e-trim is a trademark of Texas Instruments Incorporated.
All other trademarks are the property of their respective owners.

ZHCS042 –4 月 2011 年 www.ti.com.cn



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

**STRUMENTS** 

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

# **ABSOLUTE MAXIMUM RATING(1)**

over operating free-air temperature range (unless otherwise noted)

			VALUE	UNIT
Supply voltage $V_S = (V_S + V_S)^T + V_S =$		$V_S = (V+) - (V-)$	+7	V
Cianal input terminals	Voltage <sup>(2)</sup>	/oltage <sup>(2)</sup>		V
Signal input terminals	Current <sup>(2)</sup>		±10	mA
Output short-circuit <sup>(3)</sup>		Continuous		
Operating temperature		T <sub>A</sub>	-40 to +125	°C
Storage temperature		T <sub>A</sub>	-65 to +150	°C
Junction temperature		$T_J$	+150	°C

- (1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not supported.
- (2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5V beyond the supply rails should be current limited to 10mA or less.
- (3) Short-circuit to ground, one amplifier per package.

### PACKAGE INFORMATION(1)

PRODUCT	PACKAGE-LEAD	PACKAGE DESIGNATOR	PACKAGE MARKING
	SC70-5	DCK	Preview
OPA376-Q1	SOT23-5	DBV	OUHQ
	SO-8	D	Preview
OPA2376-Q1	SO-8	D	Preview
UPA2376-Q1	MSOP-8	DGK	Preview
OPA4376-Q1	TSSOP-14	PW	Preview

For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder at www.ti.com.



# ELECTRICAL CHARACTERISTICS: $V_s = +2.2V$ to +5.5V

**Boldface** limits apply over the specified temperature range:  $T_A = -40^{\circ}C$  to +125°C. At  $T_A = +25^{\circ}C$ ,  $R_L = 10k\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{O\ UT} = V_S/2$ , unless otherwise noted.

PARAMETERS		CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET VOLTAGE						
Input Offset Voltage	Vos			5	25	μV
vs Temperature	dV <sub>OS</sub> /dT	–40°C to +85°C		0.26	1	μV/°C
		-40°C to +125°C		0.32	2	μ <b>V/</b> ° <b>C</b>
vs Power Supply	PSRR	$V_S = +2.2V \text{ to } +5.5V, V_{CM} < (V+) -1.3V$		5	20	μV/V
Over Temperature		V <sub>S</sub> = +2.2V to +5.5V, V <sub>CM</sub> < (V+) - 1.3V		5		μ <b>V/V</b>
Channel Separation, dc (dual, quad)				0.5		mV/V
INPUT BIAS CURRENT				<u> </u>		
Input Bias Current	Ι <sub>Β</sub>			0.2	10	pА
Over Temperature			See T	ypical Characte	eristics	рA
Input Offset Current	Ios			0.2	10	pА
NOISE						
Input Voltage Noise, f = 0.1Hz to 10Hz				0.8		$\mu V_{PP}$
Input Voltage Noise Density, f = 1kHz	e <sub>n</sub>			7.5		nV/√ <del>Hz</del>
Input Current Noise, f = 1kHz	i <sub>n</sub>			2		fA/√ <del>Hz</del>
INPUT VOLTAGE RANGE						
Common-Mode Voltage Range	$V_{CM}$		(V-) - 0.1		(V+) + 0.1	V
Common-Mode Rejection Ratio	CMRR	(V–) < V <sub>CM</sub> < (V+) – 1.3 V	76	90		dB
INPUT CAPACITANCE	<u>'</u>					
Differential				6.5		pF
Common-Mode				13		pF
OPEN-LOOP GAIN	<u> </u>			-		<u>'</u>
Open-Loop Voltage Gain	A <sub>OL</sub>	$50\text{mV} < V_{O} < (V+) - 50\text{mV}, R_{L} = 10\text{k}\Omega$	120	134		dB
		$100 \text{mV} < \text{V}_{\text{O}} < (\text{V+}) - 100 \text{mV}, R_{\text{L}} = 2 \text{k}\Omega$	120	126		dB
FREQUENCY RESPONSE	<u> </u>	$C_L = 100pF, V_S = 5.5V$		-		<u>'</u>
Gain-Bandwidth Product	GBW			5.5		MHz
Slew Rate	SR	G = +1		2		V/µs
Settling Time 0.1%	t <sub>S</sub>	2V Step , G = +1		1.6		μs
Settling Time 0.01%	t <sub>S</sub>	2V Step , G = +1		2		μs
Overload Recovery Time		V <sub>IN</sub> × Gain > V <sub>S</sub>		0.33		μs
THD + Noise	THD+N	$V_{O} = 1V_{RMS}, G = +1, f = 1kHz, R_{L} = 10k\Omega$		0.00027		%
OUTPUT						
Voltage Output Swing from Rail		$R_L = 10k\Omega^{(1)}$		10	20	mV
		$R_L = 10k\Omega^{(2)}$		20	30	mV
Over Temperature		$R_L = 10k\Omega$			40	mV
Voltage Output Swing from Rail		$R_L = 2k\Omega^{(1)}$		40	50	mV
		$R_L = 2k\Omega^{(2)}$		50	60	mV
Over Temperature		$R_L = 2k\Omega$			80	mV
Short-Circuit Current	I <sub>SC</sub>			+30/-50		mA
Capacitive Load Drive	$C_{LOAD}$		See	Typical Characte	eristics	
Open-Loop Output Impedance	R <sub>O</sub>			150		Ω

<sup>(1)</sup> SC70-5, SOT23-5, SO-8, MSOP-8, and TSSOP-14 packages only.

<sup>(2)</sup> Wafer chip-scale package only.





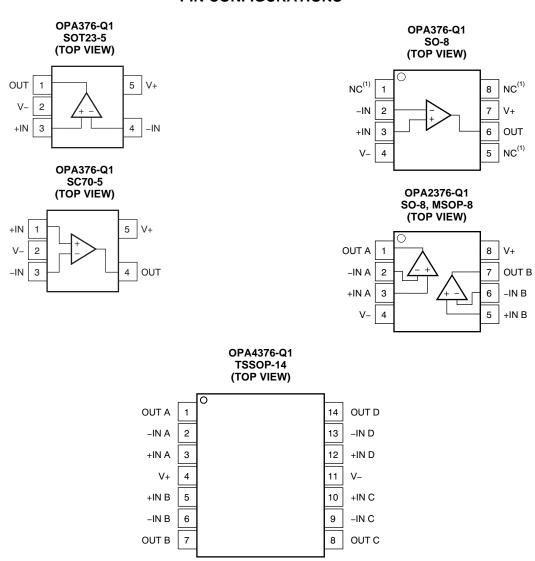
# **ELECTRICAL CHARACTERISTICS:** V<sub>s</sub> = +2.2V to +5.5V (continued)

**Boldface** limits apply over the specified temperature range:  $T_A = -40^{\circ}C$  to  $+125^{\circ}C$ . At  $T_A = +25^{\circ}C$ ,  $R_L = 10k\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{O\ UT} = V_S/2$ , unless otherwise noted.

PARAMETERS		CONDITIONS	MIN	TYP	MAX	UNIT
POWER SUPPLY						1
Specified Voltage Range	Vs		2.2		5.5	V
Operating Voltage Range				2 to 5.5		V
Quiescent Current per amplifier	IQ	$I_{O} = 0$ , $V_{S} = +5.5V$ , $V_{CM} < (V+) - 1.3V$		760	950	μA
Over Temperature					1	mA
TEMPERATURE RANGE						
Specified Range			-40		+125	°C
Operating Range			-40		+150	°C
Thermal Resistance	$\theta_{JA}$					°C/W
SC70				250		°C/W
SOT23				200		°C/W
SO-8, TSSOP-14, MSOP-8				150		°C/W



#### **PIN CONFIGURATIONS**



NOTE: (1) NC denotes no internal connection.

ZHCS042-4 月 2011 年 www.ti.com.cn

#### TYPICAL CHARACTERISTICS

At  $T_A$  = +25°C,  $V_S$  = +5V,  $R_L$  = 10k $\Omega$  connected to  $V_S/2$ ,  $V_{CM}$  =  $V_S/2$ , and  $V_{O\ UT}$  =  $V_S/2$ , unless otherwise noted.

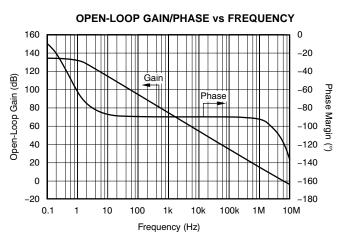


Figure 1.

#### POWER-SUPPLY AND COMMON-MODE REJECTION RATIO vs FREQUENCY 120 V(+) Power-Supply Rejection Ratio Power-Supply Rejection Ratio (dB) 100 80 Common-Mode Rejection Ratio 60 40 V(-) Power-Supply Rejection Ratio 20 0 10 100 1k 100k 10M 10k 1M

Frequency (Hz) Figure 2.

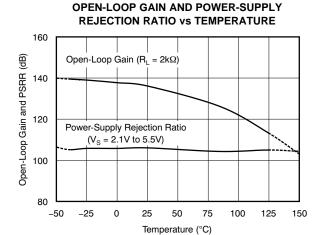


Figure 3.

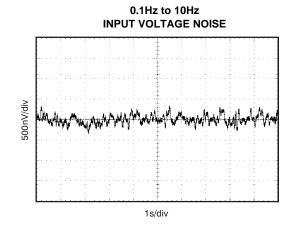
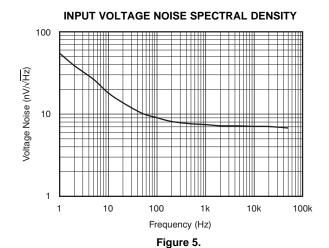
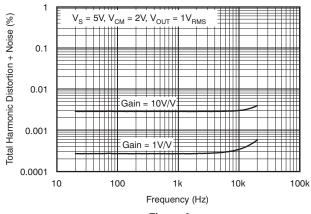


Figure 4.

**TOTAL HARMONIC DISTORTION + NOISE** 

vs FREQUENCY







## TYPICAL CHARACTERISTICS (continued)

At  $T_A$  = +25°C,  $V_S$  = +5V,  $R_L$  = 10k $\Omega$  connected to  $V_S/2$ ,  $V_{CM}$  =  $V_S/2$ , and  $V_{O\ UT}$  =  $V_S/2$ , unless otherwise noted.

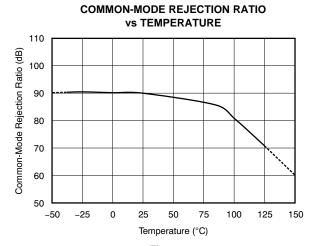


Figure 7.

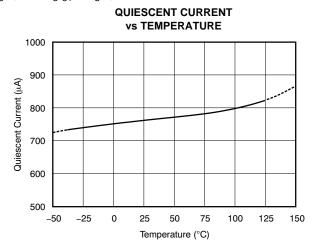


Figure 8.

**SHORT-CIRCUIT CURRENT** 

# QUIESCENT AND SHORT-CIRCUIT CURRENT VS SUPPLY VOLTAGE

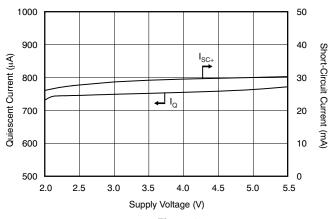


Figure 9.

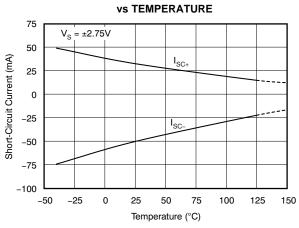


Figure 10.

#### INPUT BIAS CURRENT vs TEMPERATURE

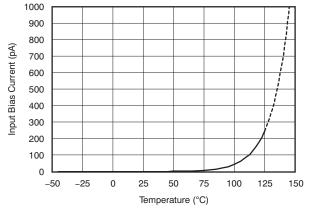


Figure 11.

#### **OUTPUT VOLTAGE vs OUTPUT CURRENT**

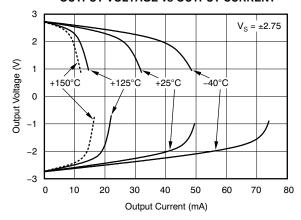


Figure 12.

ZHCS042 – 4 月 2011 年 www.ti.com.cn

### TYPICAL CHARACTERISTICS (continued)

At  $T_A$  = +25°C,  $V_S$  = +5V,  $R_L$  = 10k $\Omega$  connected to  $V_S/2$ ,  $V_{CM}$  =  $V_S/2$ , and  $V_{O\ UT}$  =  $V_S/2$ , unless otherwise noted.

# OFFSET VOLTAGE PRODUCTION DISTRIBUTION

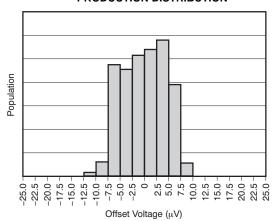


Figure 13.

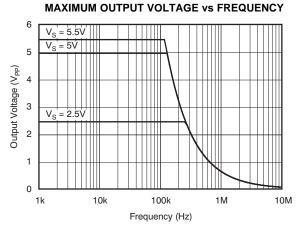


Figure 15.

#### **SMALL-SIGNAL PULSE RESPONSE**

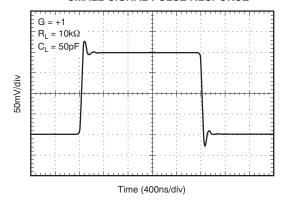


Figure 17.

#### OFFSET VOLTAGE DRIFT PRODUCTION DISTRIBUTION (-40°C to +125°C)

INSTRUMENTS

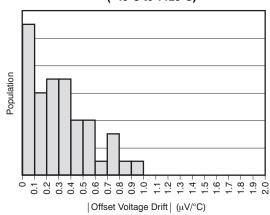


Figure 14.

#### **SMALL-SIGNAL OVERSHOOT vs LOAD CAPACITANCE**

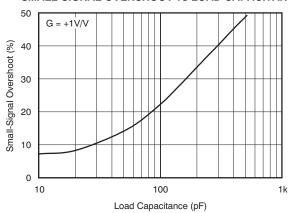


Figure 16.

#### LARGE-SIGNAL PULSE RESPONSE

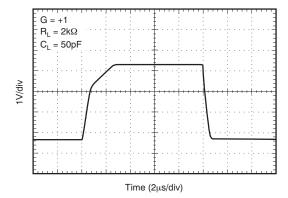
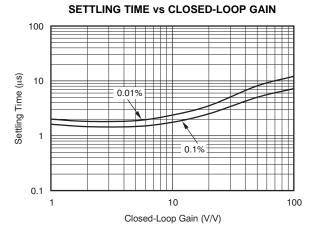


Figure 18.



# TYPICAL CHARACTERISTICS (continued)

At  $T_A$  = +25°C,  $V_S$  = +5V,  $R_L$  = 10k $\Omega$  connected to  $V_S/2$ ,  $V_{CM}$  =  $V_S/2$ , and  $V_{O\ UT}$  =  $V_S/2$ , unless otherwise noted.



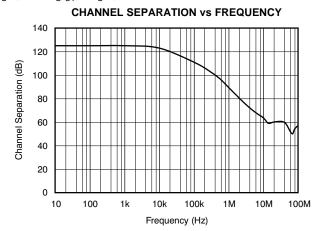
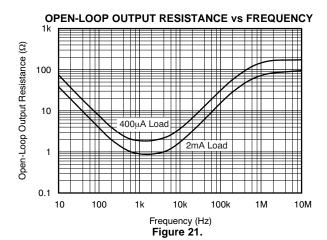


Figure 19.

Figure 20.



ZHCS042 –4 月 2011 年 www.ti.com.cn



#### APPLICATION INFORMATION

The OPA376-Q1 family of operational amplifiers is built using *e-trim*, a proprietary technique in which offset voltage is adjusted during the final steps of manufacturing. This technique compensates for performance shifts that can occur during the molding process. Through *e-trim*, the OPA376-Q1 family delivers excellent offset voltage (5 $\mu$ V, typ). Additionally, the amplifier boasts a fast slew rate, low drift, low noise, and excellent PSRR and A<sub>OL</sub>. These 5.5MHz CMOS op amps operate on 760 $\mu$ A (typ) quiescent current.

#### **OPERATING CHARACTERISTICS**

The OPA376-Q1 family of amplifiers has parameters that are fully specified from 2.2V to 5.5V (±1.1V to ±2.75V). Many of the specifications apply from -40°C to +125°C. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the Typical Characteristics.

#### **GENERAL LAYOUT GUIDELINES**

For best operational performance of the device, good printed circuit board (PCB) layout practices are required. Low-loss, 0.1µF bypass capacitors must be connected between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable to single-supply applications.

#### **BASIC AMPLIFIER CONFIGURATIONS**

The OPA376-Q1 family is unity-gain stable. It does not exhibit output phase inversion when the input is overdriven. A typical single-supply connection is shown in Figure 22. The OPA376-Q1 is configured as a basic inverting amplifier with a gain of -10V/V. This single-supply connection has an output centered on the common-mode voltage,  $V_{\text{CM}}$ . For the circuit shown, this voltage is 2.5V, but may be any value within the common-mode input voltage range.

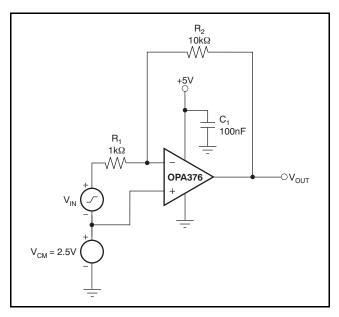


Figure 22. Basic Single-Supply Connection

#### COMMON-MODE VOLTAGE RANGE

The input common-mode voltage range of the OPA376-Q1 series extends 100mV beyond the supply rails. The offset voltage of the amplifier is very low, from approximately (V–) to (V+) – 1V, as shown in Figure 23. The offset voltage increases as common-mode voltage exceeds (V+) -1V. Common-mode rejection is specified from (V–) to (V+) - 1.3V.

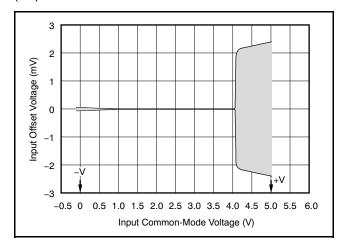


Figure 23. Offset and Common-Mode Voltage

#### INPUT AND ESD PROTECTION

The OPA376-Q1 family incorporates internal electrostatic discharge (ESD) protection circuits on all pins. In the case of input and output pins, this protection primarily consists of current steering diodes connected between the input power-supply pins. These ESD protection diodes also provide in-circuit, input overdrive protection, as long as the current is limited to 10mA as stated in the Absolute Maximum Ratings. Figure 24 shows how a series input resistor may be added to the driven input to limit the input current. The added resistor contributes thermal noise at the amplifier input and its value should be kept to a minimum in noise-sensitive applications.

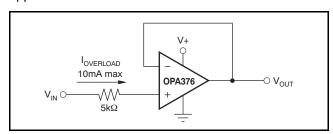


Figure 24. Input Current Protection

#### **CAPACITIVE LOAD AND STABILITY**

The OPA376-Q1 series of amplifiers may be used in applications where driving a capacitive load is required. As with all op amps, there may be specific instances where the OPAx376 can become unstable, leading to oscillation. The particular op amp circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether an amplifier will be stable in operation. An op amp in the unity-gain (+1V/V) buffer configuration and driving a capacitive load exhibits a greater tendency to be unstable than an amplifier operated at a higher noise gain. The capacitive load, in conjunction with the op amp output resistance, creates a pole within the feedback loop that degrades the phase margin. The degradation of the phase margin increases as the capacitive loading increases.

The OPAx376 in a unity-gain configuration can directly drive up to 250pF pure capacitive load. Increasing the gain enhances the ability of the amplifier to drive greater capacitive loads; see the typical characteristic plot, Small-Signal Overshoot vs Capacitive Load. In unity-gain configurations, capacitive load drive can be improved by inserting a small (10 $\Omega$  to 20 $\Omega$ ) resistor,  $R_{S}$ , in series with the output, as shown in Figure 25. This resistor significantly reduces ringing while maintaining dc performance for purely capacitive loads. However, if there is a resistive load in parallel with the capacitive

load, a voltage divider is created, introducing a gain error at the output and slightly reducing the output swing. The error introduced is proportional to the ratio  $R_S/R_L$ , and is generally negligible at low output current levels.

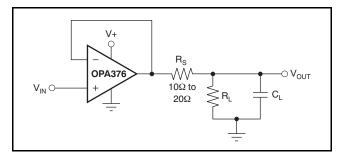


Figure 25. Improving Capacitive Load Drive

#### **ACTIVE FILTERING**

The OPA376-Q1 series is well-suited for filter applications requiring a wide bandwidth, fast slew rate, low-noise, single-supply operational amplifier. Figure 26 shows a 50kHz, 2nd-order, low-pass filter. The components have been selected to provide a maximally-flat Butterworth response. Beyond the cutoff frequency, roll-off is -40dB/dec. The Butterworth response is ideal for applications requiring predictable gain characteristics such as the anti-aliasing filter used ahead of an analog-to-digital converter (ADC).

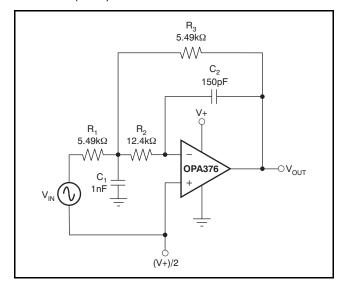


Figure 26. Second-Order Butterworth 50kHz Low-Pass Filter

#### **PHOTOSENSITIVITY**

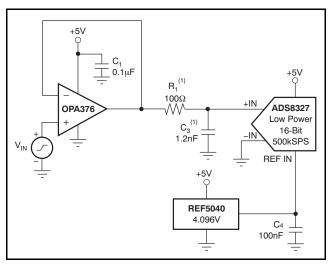
Although the OPA2376YZD package has a protective backside coating that reduces the amount of light exposure on the die, unless fully shielded, ambient light can reach the active region of the device. Input ZHCS042 –4 月 2011 年 www.ti.com.cn



bias current for the package is specified in the absence of light. Depending on the amount of light exposure in a given application, an increase in bias current, and possible increases in offset voltage should be expected. Fluorescent lighting may introduce noise or hum because of the time-varying light output. Best layout practices include end-product packaging that provides shielding from possible light sources during operation.

# DRIVING AN ANALOG-TO-DIGITAL CONVERTER

The low noise and wide gain bandwidth of the OPA376-Q1 family make it an ideal driver for ADCs. Figure 27 illustrates the OPA376-Q1 driving an ADS8327, 16-bit, 250kSPS converter. The amplifier is connected as a unity-gain, noninverting buffer.



NOTE: (1) Suggested value; may require adjustment based on specific application.

Figure 27. Driving an ADS8327

#### PHANTOM-POWERED MICROPHONE

The circuit shown in Figure 28 depicts how a remote microphone amplifier can be powered by a phantom source on the output side of the signal cable. The cable serves double duty, carrying both the differential output signal from and dc power to the microphone amplifier stage.

An OPA2376-Q1 serves as a single-ended input to a differential output amplifier with a 6dB gain. Common-mode bias for the two op amps is provided by the dc voltage developed across the electret microphone element. A 48V phantom supply is reduced to 5.1V by the series  $6.8k\Omega$  resistors on the output side of the cable, and the  $4.7k\Omega$  and zener diode on the input side of the cable. AC coupling blocks the different dc voltage levels from each other on each end of the cable.



An INA163 instrumentation amplifier provides differential inputs and receives the balanced audio signals from the cable.

The INA163 gain may be set from 0dB to 80dB by selecting the  $R_{\rm G}$  value. The INA163 circuit is typical of the input circuitry used in mixing consoles.

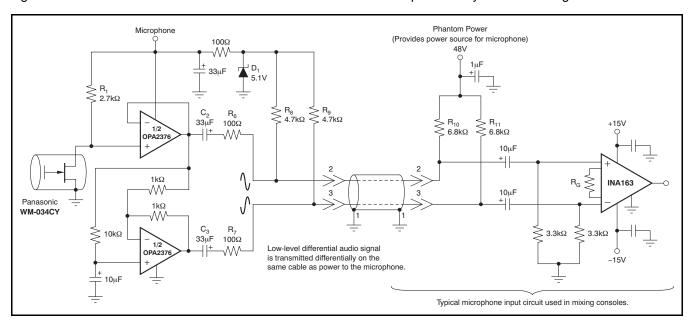
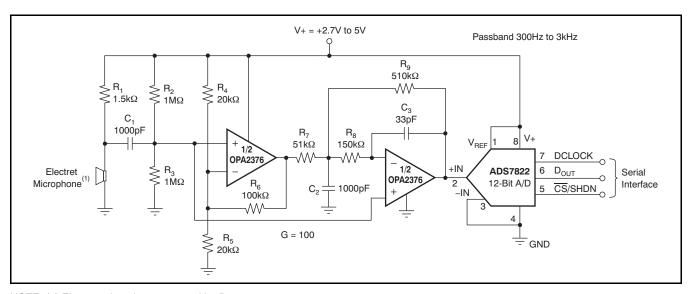


Figure 28. Phantom-Powered Electret Microphone



NOTE: (1) Electret microphone powered by  $R_1$ .

Figure 29. OPA2376-Q1 as a Speech Bandpass Filtered Data Acquisition System

## PACKAGE OPTION ADDENDUM



ww.ti.com 29-Apr-2011

#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Peak Temp <sup>(3)</sup>	Samples (Requires Login)
TXS4555RGTR	ACTIVE	QFN	RGT	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
TXS4555RUTR	ACTIVE	UQFN	RUT	12	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

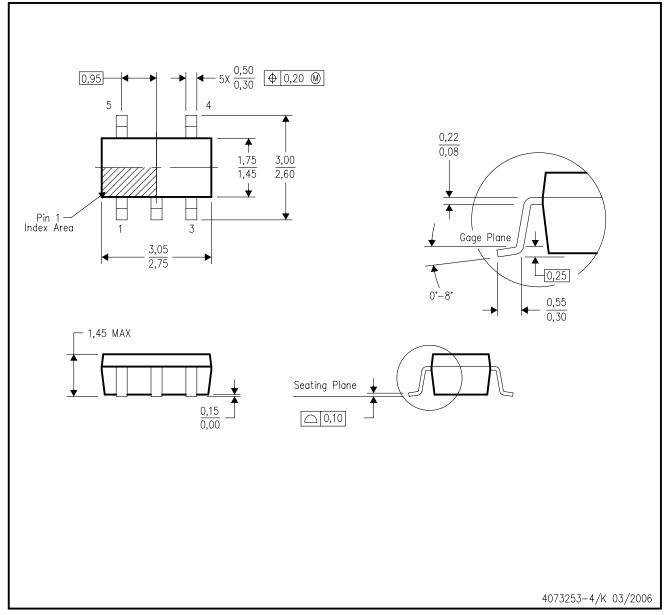
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# DBV (R-PDSO-G5)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-178 Variation AA.

#### 重要声明

德州仪器(TI) 及其下属子公司有权在不事先通知的情况下,随时对所提供的产品和服务进行更正、修改、增强、改进或其它更改,并有权随时中止提供任何产品和服务。客户在下订单前应获取最新的相关信息,并验证这些信息是否完整且是最新的。所有产品的销售都遵循在订单确认时所提供的TI 销售条款与条件。

TI 保证其所销售的硬件产品的性能符合 TI 标准保修的适用规范。仅在 TI 保证的范围内,且 TI 认为有必要时才会使用测试或其它质量控制技术。除非政府做出了硬性规定,否则没有必要对每种产品的所有参数进行测试。

TI 对应用帮助或客户产品设计不承担任何义务。客户应对其使用TI 组件的产品和应用自行负责。为尽量减小与客户产品和应用相关的风险,客户应提供充分的设计与操作安全措施。

TI 不对任何TI 专利权、版权、屏蔽作品权或其它与使用了TI 产品或服务的组合设备、机器、流程相关的TI 知识产权中授予的直接或隐含权限作出任何保证或解释。TI 所发布的与第三方产品或服务有关的信息,不能构成从TI 获得使用这些产品或服务的许可、授权、或认可。使用此类信息可能需要获得第三方的专利权或其它知识产权方面的许可,或是TI 的专利权或其它知识产权方面的许可。

对于TI 的产品手册或数据表,仅在没有对内容进行任何篡改且带有相关授权、条件、限制和声明的情况下才允许进行复制。在复制信息的过程中对内容的篡改属于非法的、欺诈性商业行为。TI 对此类篡改过的文件不承担任何责任。

在转售TI 产品或服务时,如果存在对产品或服务参数的虚假陈述,则会失去相关TI 产品或服务的明示或暗示授权,且这是非法的、欺诈性商业行为。TI 对此类虚假陈述不承担任何责任。

TI产品未获得用于关键的安全应用中的授权,例如生命支持应用(在该类应用中一旦TI产品故障将预计造成重大的人员伤亡),除非各方官员已经达成了专门管控此类使用的协议。购买者的购买行为即表示,他们具备有关其应用安全以及规章衍生所需的所有专业技术和知识,并且认可和同意,尽管任何应用相关信息或支持仍可能由TI提供,但他们将独力负责满足在关键安全应用中使用其产品及TI产品所需的所有法律、法规和安全相关要求。此外,购买者必须全额赔偿因在此类关键安全应用中使用TI产品而对TI及其代表造成的损失。

TI 产品并非设计或专门用于军事/航空应用,以及环境方面的产品,除非TI 特别注明该产品属于"军用"或"增强型塑料"产品。只 有TI 指定的军用产品才满足军用规格。购买者认可并同意,对TI 未指定军用的产品进行军事方面的应用,风险由购买者单独承担,并且独力负责在此类相关使用中满足所有法律和法规要求。

TI 产品并非设计或专门用于汽车应用以及环境方面的产品,除非TI 特别注明该产品符合ISO/TS 16949 要求。购买者认可并同意,如果他们在汽车应用中使用任何未被指定的产品,TI 对未能满足应用所需要求不承担任何责任。

可访问以下URL 地址以获取有关其它TI 产品和应用解决方案的信息:

	产品		应用
数字音频	www.ti.com.cn/audio	通信与电信	www.ti.com.cn/telecom
放大器和线性器件	http://www.ti.com.cn/amplifiers	计算机及周边	www.ti.com.cn/computer
数据转换器	http://www.ti.com.cn/dataconverters	消费电子	www.ti.com/consumer-apps
DLP®产品	www.dlp.com	能源	www.ti.com/energy
DSP - 数字信号处理器	http://www.ti.com.cn/dsp	工业应用	www.ti.com.cn/industrial
时钟和计时器	http://www.ti.com.cn/clockandtimers	医疗电子	www.ti.com.cn/medical
接口	http://www.ti.com.cn/interface	安防应用	www.ti.com.cn/security
逻辑	http://www.ti.com.cn/logic	汽车电子	www.ti.com.cn/automotive
电源管理	http:///www.ti.com.cn/power	视频和影像	www.ti.com.cn/video
微控制器 (MCU)	http://www.ti.com.cn/microcontrollers	无线通信	www.ti.com.cn/wireless
RFID 系统	http://www.ti.com.cn/rfidsys		
RF/IF 和 ZigBee® 解决方案	www.ti.com.cn/radiofre		
	TI E2E 工程师社区	http://e2e.ti.com/cn/	

邮寄地址: 上海市浦东新区世纪大道 1568 号,中建大厦 32 楼 邮政编码: 200122 Copyright © 2011 德州仪器 半导体技术(上海)有限公司